

TOSHIBA Transistor Silicon PNP Epitaxial Type

# TPC6603

Switching Applications

DC/DC Converter Applications

Strobe Flash Applications

- High DC current gain:  $h_{FE} = 200$  to  $500$  ( $I_C = -0.5$  A)
- Low collector-emitter saturation:  $V_{CE(sat)} = -0.19$  V (max)
- High-speed switching:  $t_f = 40$  ns (typ.)

## Absolute Maximum Ratings (Ta = 25°C)

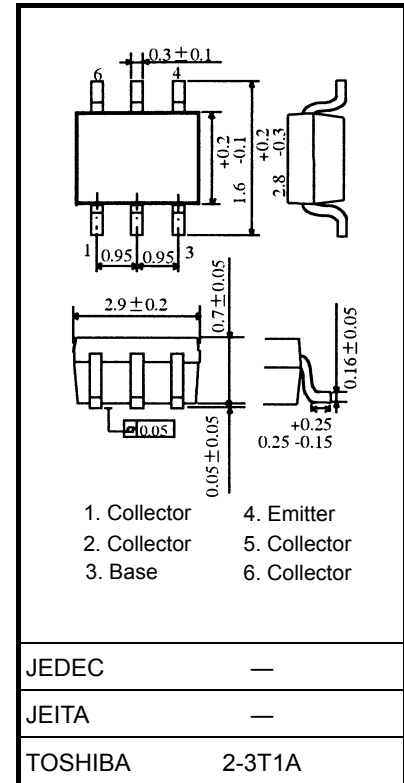
Characteristic		Symbol	Rating	Unit
Collector-base voltage		$V_{CBO}$	-30	V
Collector-emitter voltage		$V_{CEO}$	-20	V
Emitter-base voltage		$V_{EBO}$	-7	V
Collector current	DC	$I_C$	-3.0	A
	Pulse	$I_{CP}$	-5.0	
Base current		$I_B$	-0.3	mA
Collector power dissipation	DC	$P_C$ (Note 1)	0.8	W
	$t = 10$ s		1.6	
Junction temperature		$T_j$	150	°C
Storage temperature range		$T_{stg}$	-55 to 150	°C

Note 1: Mounted on an FR4 board (glass-epoxy; 1.6 mm thick; Cu area, 645 mm<sup>2</sup>)

Note 2: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

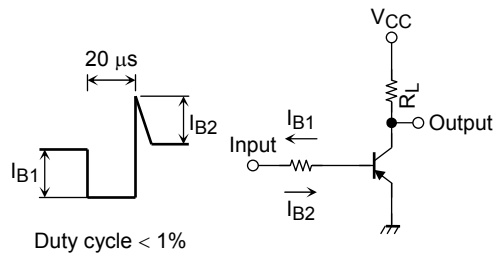
Unit: mm



Weight: 0.01 g (typ.)

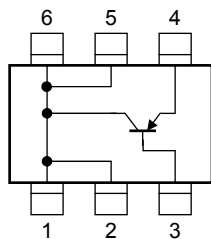
**Electrical Characteristics (Ta = 25°C)**

Characteristic		Symbol	Test Condition	Min	Typ.	Max	Unit
Collector cutoff current		$I_{CBO}$	$V_{CB} = -30\text{ V}, I_E = 0$	—	—	-100	nA
Emitter cutoff current		$I_{EBO}$	$V_{EB} = -7\text{ V}, I_C = 0$	—	—	-100	nA
Collector-emitter breakdown voltage		$V_{(BR)CEO}$	$I_C = -10\text{ mA}, I_B = 0$	-20	—	—	V
DC current gain		$h_{FE(1)}$	$V_{CE} = -2\text{ V}, I_C = -0.5\text{ A}$	200	—	500	
		$h_{FE(2)}$	$V_{CE} = -2\text{ V}, I_C = -1.6\text{ A}$	100	—	—	
Collector-emitter saturation voltage		$V_{CE(sat)}$	$I_C = -1.6\text{ A}, I_B = -53\text{ mA}$	—	—	-0.19	V
Base-emitter saturation voltage		$V_{BE(sat)}$	$I_C = -1.6\text{ A}, I_B = -53\text{ mA}$	—	—	-1.10	V
Collector output capacitance		$C_{ob}$	$V_{CB} = -10\text{ V}, I_E = 0, f = 1\text{ MHz}$	—	28	—	pF
Switching time	Rise time	$t_r$	See Figure 1 circuit diagram $V_{CC} \approx -12\text{ V}, R_L = 7.5\ \Omega$ $I_{B1} = -I_{B2} = -53.3\text{ mA}$	—	70	—	ns
	Storage time	$t_{stg}$		—	150	—	
	Fall time	$t_f$		—	40	—	

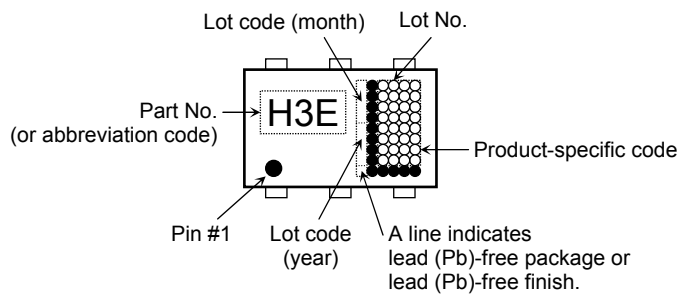


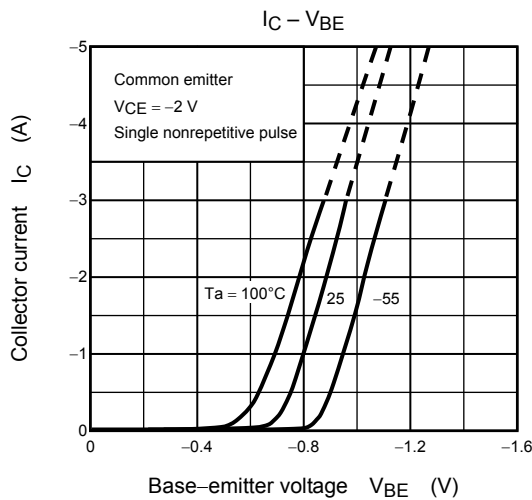
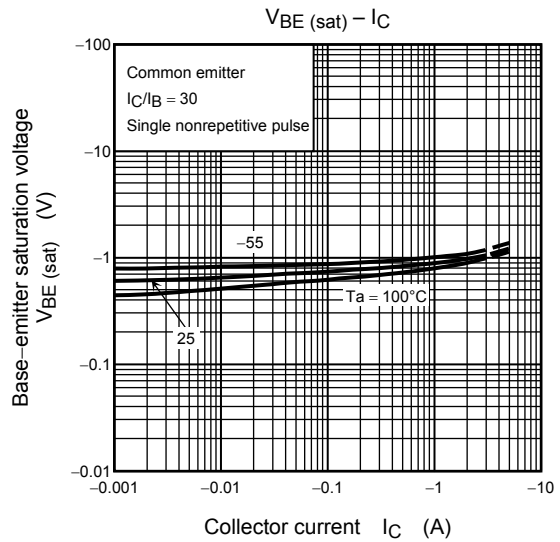
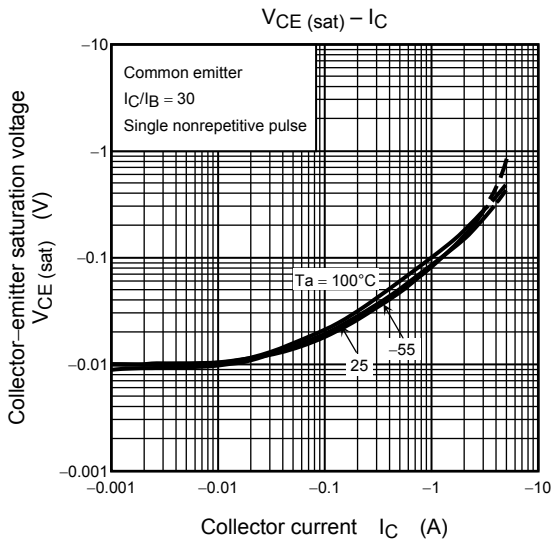
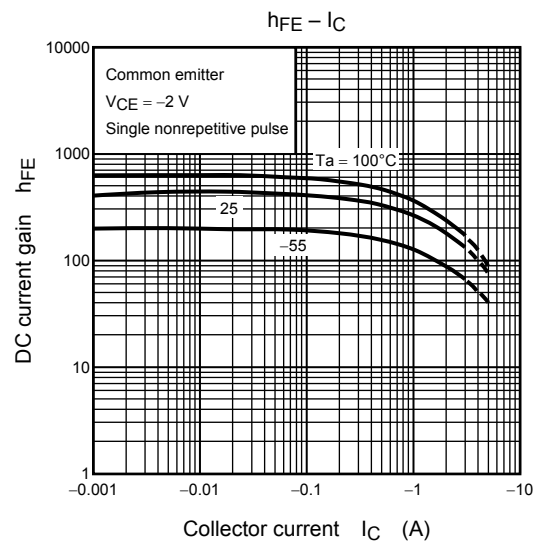
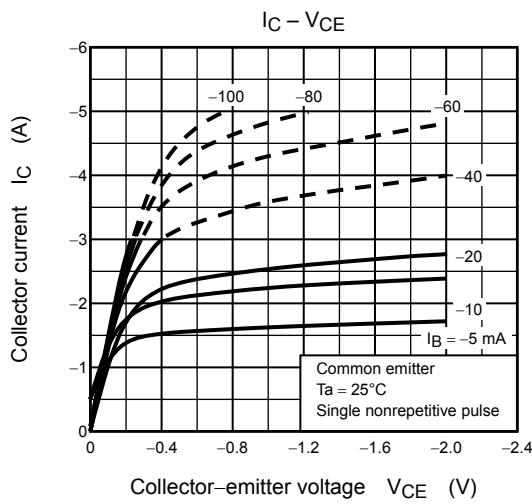
**Figure 1. Switching Time Test Circuit**

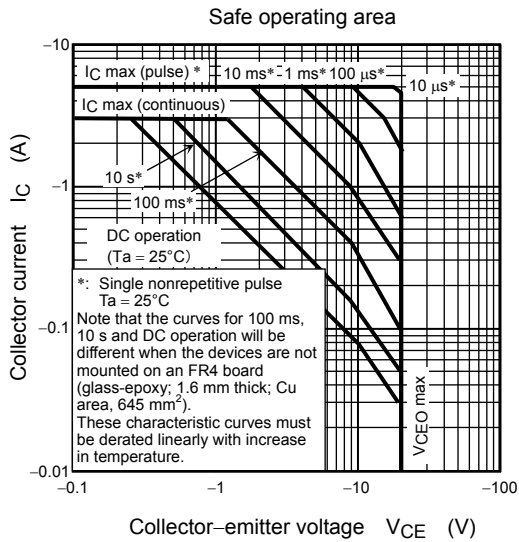
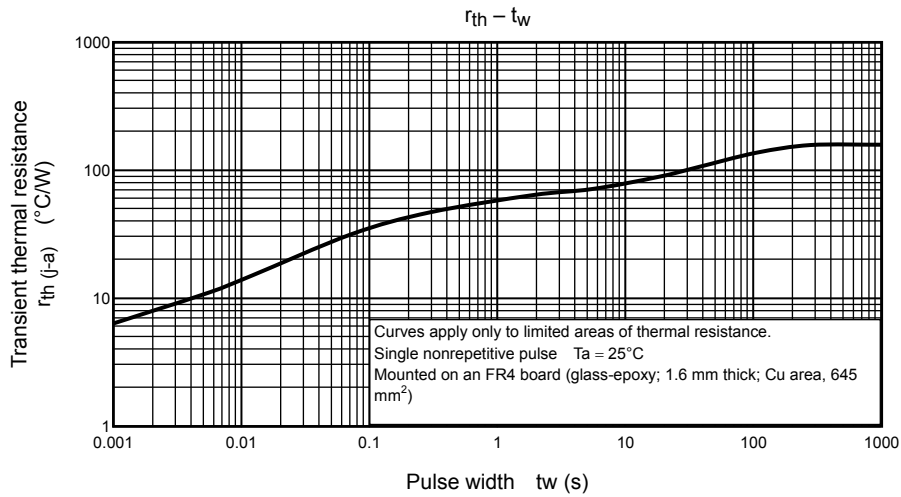
**Circuit configuration (Top View)**



**Marking**







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